

BUD42D

High Speed, High Gain Bipolar NPN Transistor with Antisaturation Network and Transient Voltage Suppression Capability

The BUD42D is a state-of-the-art bipolar transistor. Tight dynamic characteristics and lot to lot minimum spread make it ideally suitable for light ballast applications.

Features

- Free-Wheeling Diode Built-In
- Flat DC Current Gain
- Fast Switching Times and Tight Distribution
- “6 Sigma” Process Providing Tight and Reproducible Parameter Spreads
- Epoxy Meets UL 94 V-0 @ 0.125 in
- These Devices are Pb-Free and are RoHS Compliant

Two Versions

- BUD42D-1: Case 369D for Insertion Mode
- BUD42D, BUD42DT4: Case 369C for Surface Mount Mode

MAXIMUM RATINGS

| Rating | Symbol | Value | Unit |
|--|----------------|----------------|--------------------------|
| Collector-Emitter Sustaining Voltage | V_{CEO} | 350 | Vdc |
| Collector-Base Breakdown Voltage | V_{CBO} | 650 | Vdc |
| Collector-Emitter Breakdown Voltage | V_{CES} | 650 | Vdc |
| Emitter-Base Voltage | V_{EBO} | 9 | Vdc |
| Collector Current - Continuous | I_C | 4.0 | Adc |
| Collector Current - Peak (Note 1) | I_{CM} | 8.0 | Adc |
| Base Current - Continuous | I_B | 1.0 | Adc |
| Base Current - Peak (Note 1) | I_{BM} | 2.0 | Adc |
| Total Device Dissipation @ $T_C = 25^\circ\text{C}$ Derate above 25°C | P_D | 25 0.2 | W W/ $^\circ\text{C}$ |
| Operating and Storage Temperature | T_J, T_{stg} | -65 to +150 | $^\circ\text{C}$ |
| ESD - Human Body Model | HBM | 3B | V |
| ESD - Machine Model | MM | C | V |

TYPICAL GAIN

| | | | |
|--|----------|----|---|
| Typical Gain @ $I_C = 1\text{ A}, V_{CE} = 2\text{ V}$ | h_{FE} | 13 | - |
| Typical Gain @ $I_C = 0.3\text{ A}, V_{CE} = 1\text{ V}$ | h_{FE} | 16 | - |

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

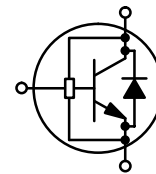
1. Pulse Test: Pulse Width = 5.0 ms, Duty Cycle = 10%10



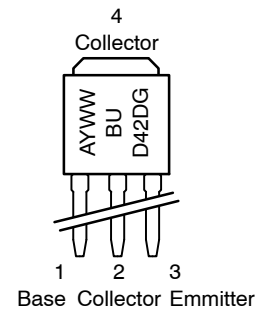
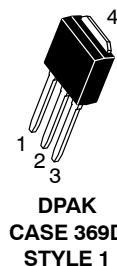
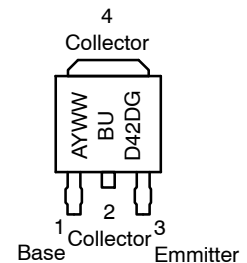
ON Semiconductor®

<http://onsemi.com>

**4 AMPERES
650 VOLTS, 25 WATTS
POWER TRANSISTOR**



MARKING DIAGRAMS



A = Assembly Location
Y = Year
WW = Work Week
BUD43D = Device Code
G = Pb-Free Package

ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 10 of this data sheet.

BUD42D

THERMAL CHARACTERISTICS

| Characteristic | Symbol | Value | Unit |
|---|-----------------|-------|-----------------------------|
| Thermal Resistance, Junction-to-Case | $R_{\theta JC}$ | 5.0 | $^{\circ}\text{C}/\text{W}$ |
| Thermal Resistance, Junction-to-Ambient | $R_{\theta JA}$ | 71.4 | $^{\circ}\text{C}/\text{W}$ |
| Maximum Lead Temperature for Soldering Purposes: 1/8 in from Case for 5 seconds | T_L | 260 | $^{\circ}\text{C}$ |

ELECTRICAL CHARACTERISTICS ($T_C = 25^{\circ}\text{C}$ unless otherwise noted)

| Characteristic | Symbol | Min | Typ | Max | Unit |
|----------------|--------|-----|-----|-----|------|
|----------------|--------|-----|-----|-----|------|

OFF CHARACTERISTICS

| | | | | | | |
|--|----------------|-------------------------------|-----|-----|-----------------|-----------------|
| Collector-Emitter Sustaining Voltage ($I_C = 100\text{ mA}$, $L = 25\text{ mH}$) | $V_{CEO(sus)}$ | 350 | 430 | - | Vdc | |
| Collector-Base Breakdown Voltage ($I_{CBO} = 1\text{ mA}$) | V_{CBO} | 650 | 780 | - | Vdc | |
| Emitter-Base Breakdown Voltage ($I_{EBO} = 1\text{ mA}$) | V_{EBO} | 9.0 | 12 | - | Vdc | |
| Collector Cutoff Current ($V_{CE} = \text{Rated } V_{CEO}$, $I_B = 0$) | I_{CEO} | @ $T_C = 25^{\circ}\text{C}$ | - | - | 100 | μAdc |
| | | @ $T_C = 125^{\circ}\text{C}$ | - | - | 200 | |
| Collector Cutoff Current ($V_{CE} = \text{Rated } V_{CES}$, $V_{EB} = 0$) | I_{CES} | @ $T_C = 25^{\circ}\text{C}$ | - | - | 10 | μAdc |
| | | @ $T_C = 125^{\circ}\text{C}$ | - | - | 200 | |
| Emitter-Cutoff Current ($V_{EB} = 9\text{ Vdc}$, $I_C = 0$) | I_{EBO} | - | - | 100 | μAdc | |

ON CHARACTERISTICS

| | | | | | |
|---|---------------|-----------|----------|--------|-----|
| Base-Emitter Saturation Voltage ($I_C = 1\text{ Adc}$, $I_B = 0.2\text{ Adc}$) | $V_{BE(sat)}$ | - | 0.85 | 1.2 | Vdc |
| Collector-Emitter Saturation Voltage ($I_C = 2\text{ Adc}$, $I_B = 0.5\text{ Adc}$) | $V_{CE(sat)}$ | - | 0.2 | 1.0 | Vdc |
| DC Current Gain ($I_C = 1\text{ Adc}$, $V_{CE} = 2\text{ Vdc}$) ($I_C = 2\text{ Adc}$, $V_{CE} = 5\text{ Vdc}$) | h_{FE} | 8.0 10 | 13 12 | - - | - |

DIODE CHARACTERISTICS

| | | | | | |
|--|----------|---|-----|-----|---|
| Forward Diode Voltage ($I_{EC} = 1.0\text{ Adc}$) | V_{EC} | - | 0.9 | 1.5 | V |
|--|----------|---|-----|-----|---|

SWITCHING CHARACTERISTICS: Resistive Load (D.C. $\leq 10\%$, Pulse Width = 40 μs)

| | | | | | |
|---|-----------|-----|---|------|---------------|
| Turn-Off Time ($I_C = 1.2\text{ Adc}$, $I_{B1} = 0.4\text{ A}$, $I_{B2} = 0.1\text{ A}$, $V_{CC} = 300\text{ V}$) | T_{off} | 4.6 | - | 6.55 | μs |
| Fall Time ($I_C = 2.5\text{ Adc}$, $I_{B1} = I_{B2} = 0.5\text{ A}$, $V_{CC} = 150\text{ V}$, $V_{BE} = -2\text{ V}$) | T_f | - | - | 0.8 | μs |

DYNAMIC SATURATION VOLTAGE

| | | | | | | | | |
|--|---|-------------------|---|----------------|---|------|---|---|
| Dynamic Saturation Voltage: Determined 1 μs and 3 μs respectively after rising I_{B1} reaches 90% of final I_{B1} | $I_C = 400\text{ mA}$ $I_{B1} = 40\text{ mA}$ $V_{CC} = 300\text{ V}$ | @ 1 μs | @ $T_C = 25^{\circ}\text{C}$ @ $T_C = 125^{\circ}\text{C}$ | $V_{CE(dsat)}$ | - | 2.8 | - | V |
| | | @ 3 μs | @ $T_C = 25^{\circ}\text{C}$ @ $T_C = 125^{\circ}\text{C}$ | | - | 3.2 | - | |
| | $I_C = 1\text{ A}$ $I_{B1} = 200\text{ mA}$ $V_{CC} = 300\text{ V}$ | @ 1 μs | @ $T_C = 25^{\circ}\text{C}$ @ $T_C = 125^{\circ}\text{C}$ | | - | 0.75 | - | |
| | | @ 3 μs | @ $T_C = 25^{\circ}\text{C}$ @ $T_C = 125^{\circ}\text{C}$ | | - | 1.3 | - | |
| | | @ 1 μs | @ $T_C = 25^{\circ}\text{C}$ @ $T_C = 125^{\circ}\text{C}$ | | - | 2.1 | - | |
| | | @ 3 μs | @ $T_C = 25^{\circ}\text{C}$ @ $T_C = 125^{\circ}\text{C}$ | | - | 4.7 | - | |
| | | | | | - | 0.35 | - | |
| | | | | | - | 0.6 | - | |

TYPICAL STATIC CHARACTERISTICS

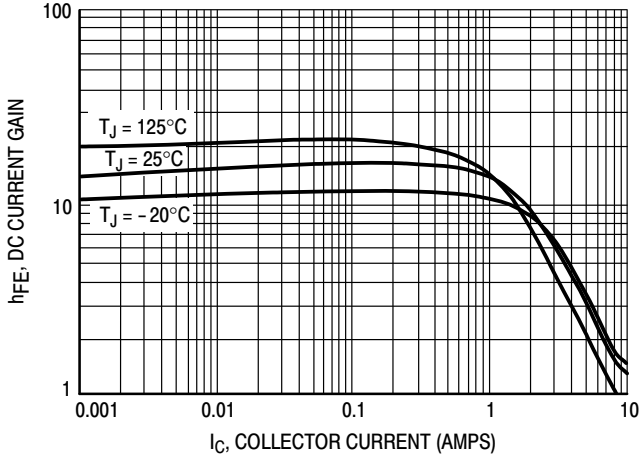


Figure 1. DC Current Gain @ $V_{CE} = 1\text{ V}$

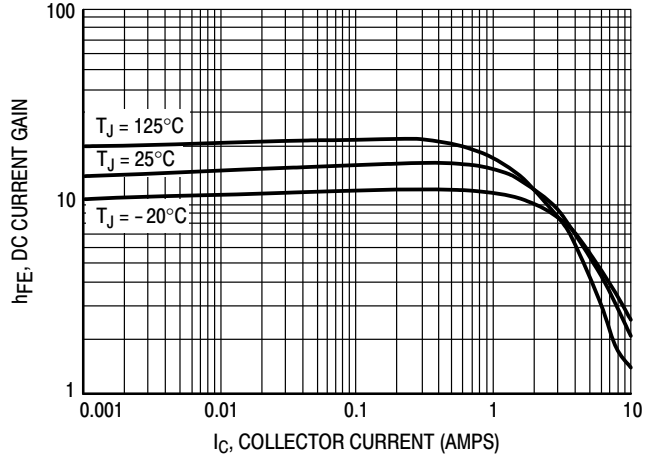


Figure 2. DC Current Gain @ $V_{CE} = 5\text{ V}$

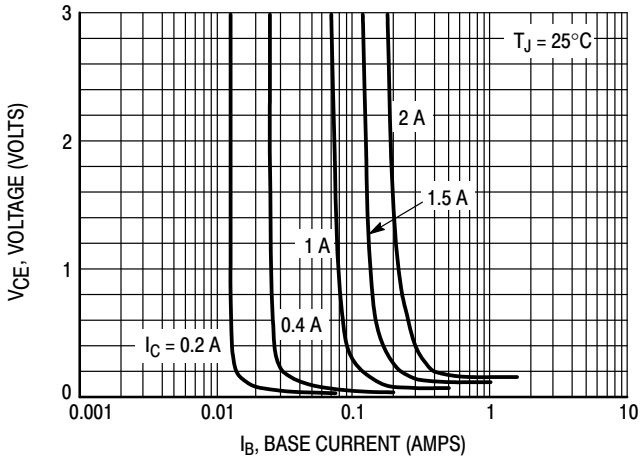


Figure 3. Collector Saturation Region

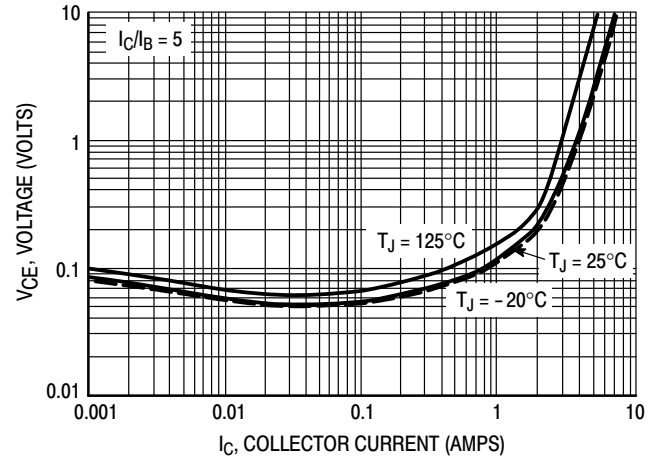


Figure 4. Collector-Emitter Saturation Voltage

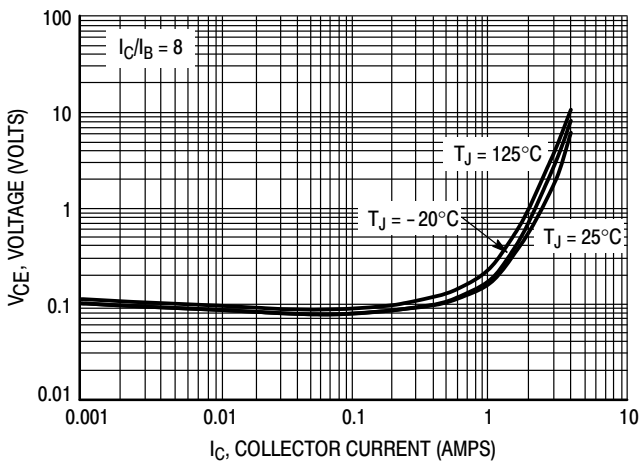


Figure 5. Collector-Emitter Saturation Voltage

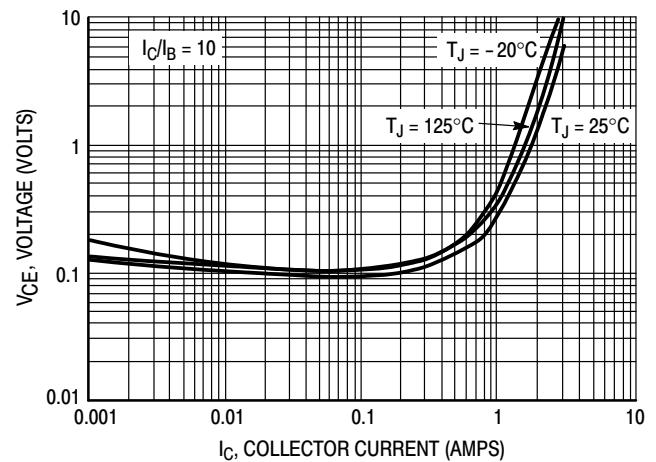


Figure 6. Collector-Emitter Saturation Voltage

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TYPICAL STATIC CHARACTERISTICS

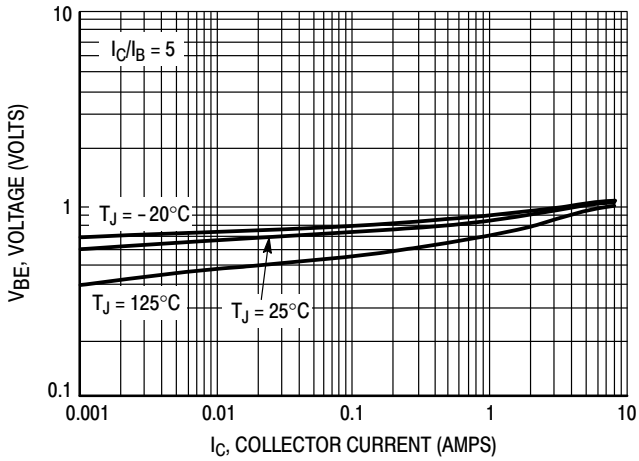


Figure 7. Base-Emitter Saturation Region

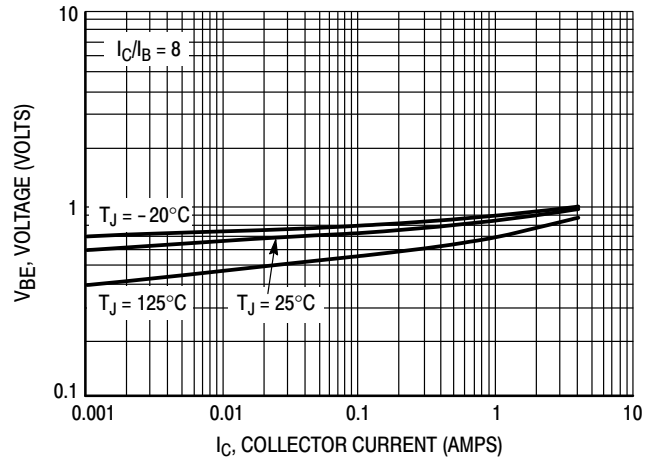


Figure 8. Base-Emitter Saturation Region

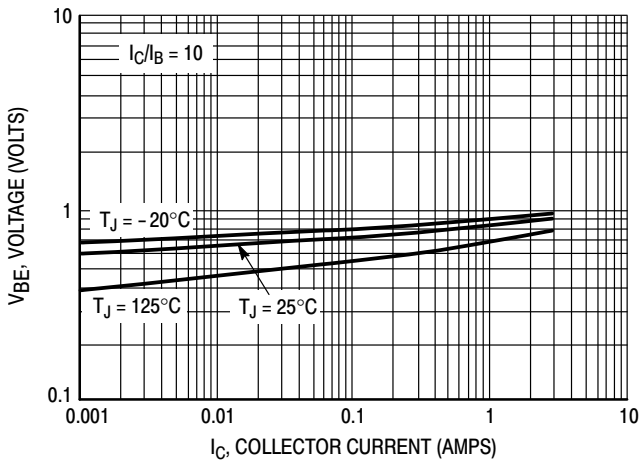


Figure 9. Base-Emitter Saturation Region

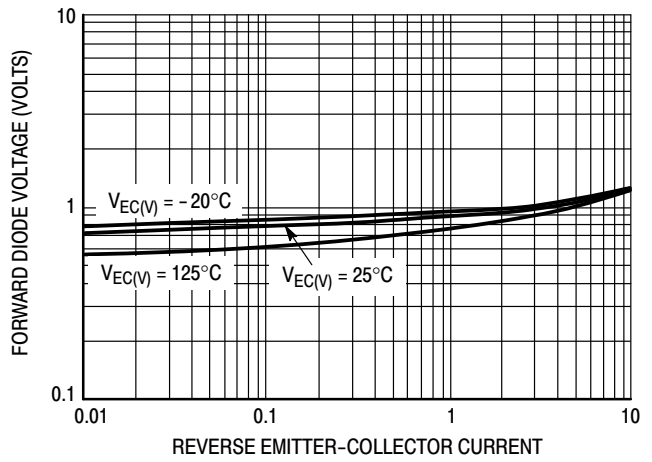


Figure 10. Forward Diode Voltage

TYPICAL SWITCHING CHARACTERISTICS

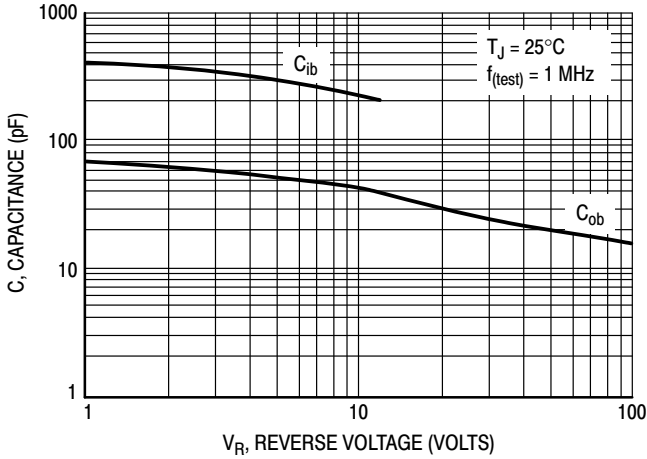


Figure 11. Capacitance

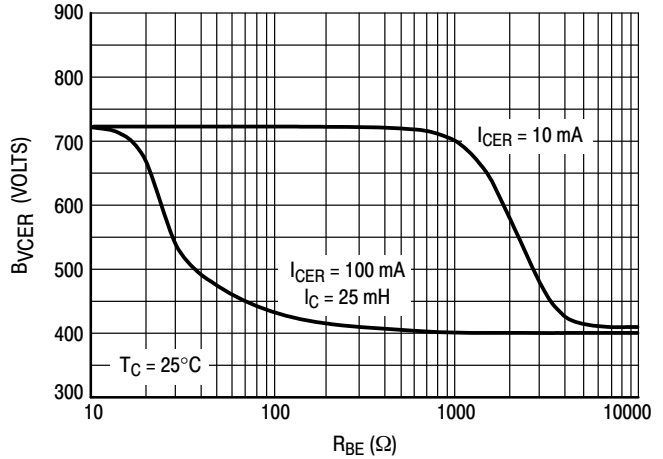


Figure 12. $B_{VCEr} = f(R_{BE})$

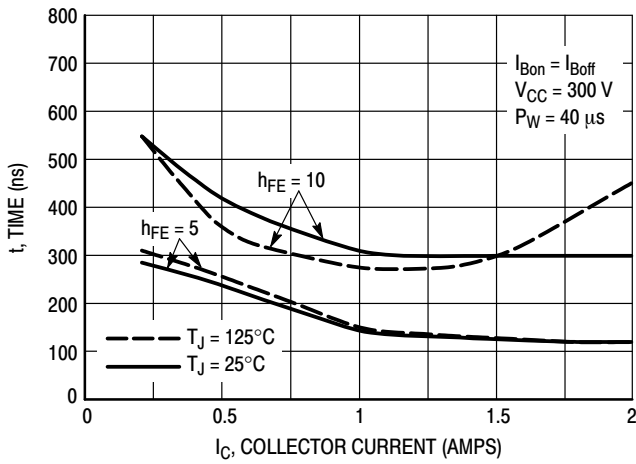


Figure 13. Resistive Switching, t_{on}

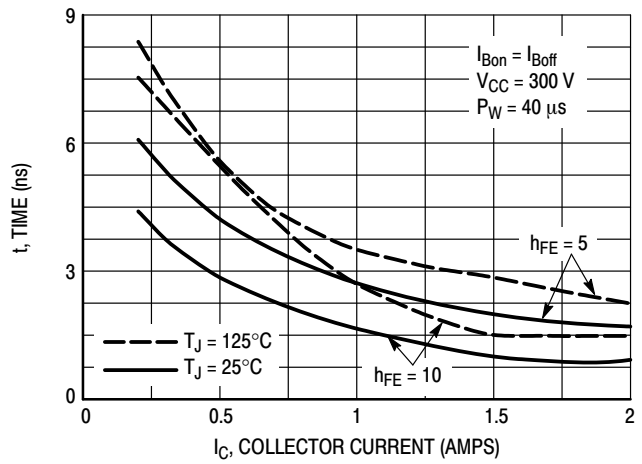


Figure 14. Resistive Switching, t_{off}

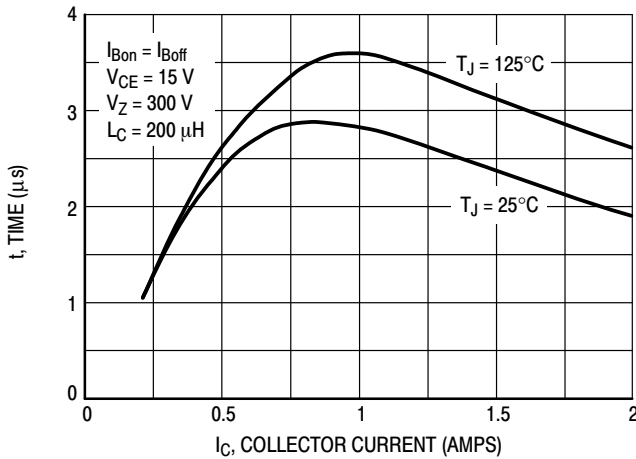


Figure 15. Inductive Storage Time, t_{si} @ $h_{FE} = 5$

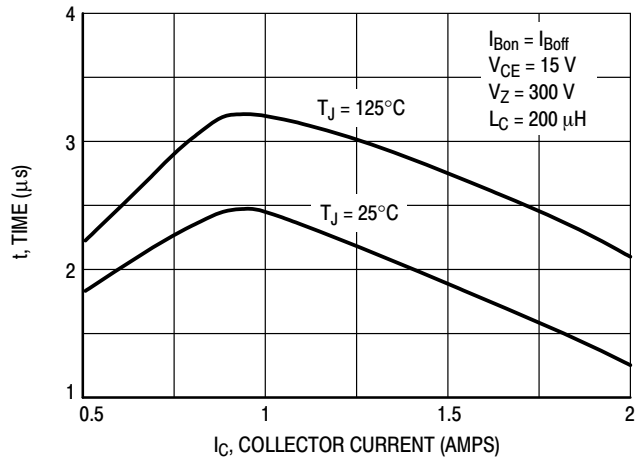


Figure 16. Inductive Storage Time, t_{si} @ $h_{FE} = 10$

TYPICAL SWITCHING CHARACTERISTICS

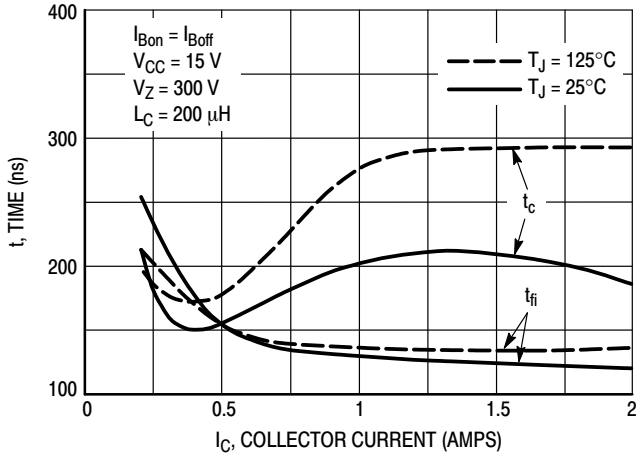


Figure 17. Inductive Fall and Cross Over Time, t_{fi} and t_c @ $h_{FE} = 5$

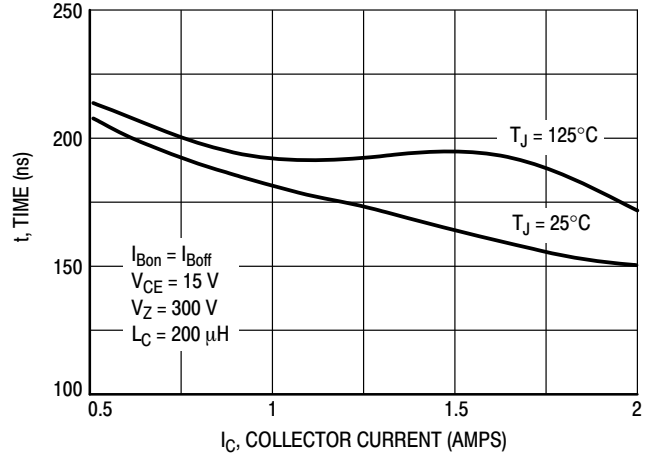


Figure 18. Inductive Fall Time, t_{fi} @ $h_{FE} = 10$

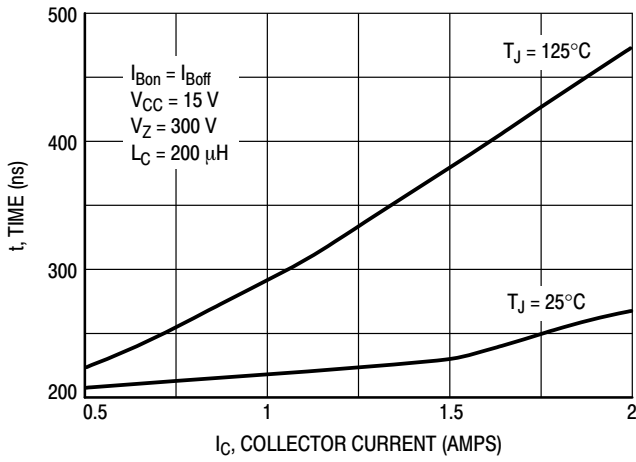


Figure 19. Inductive Cross Over Time, t_c @ $h_{FE} = 10$

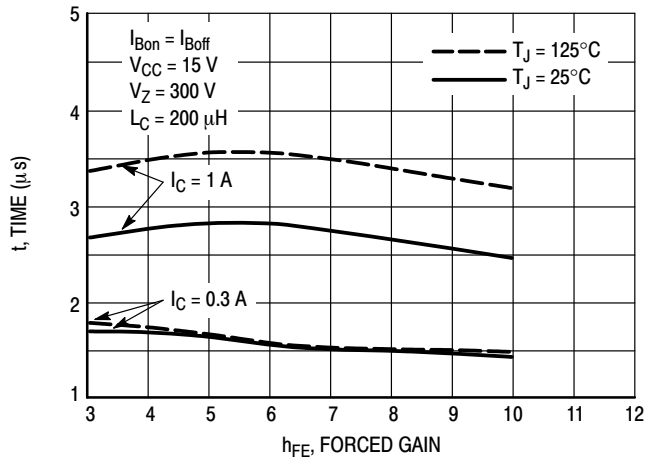


Figure 20. Inductive Storage Time, t_{si}

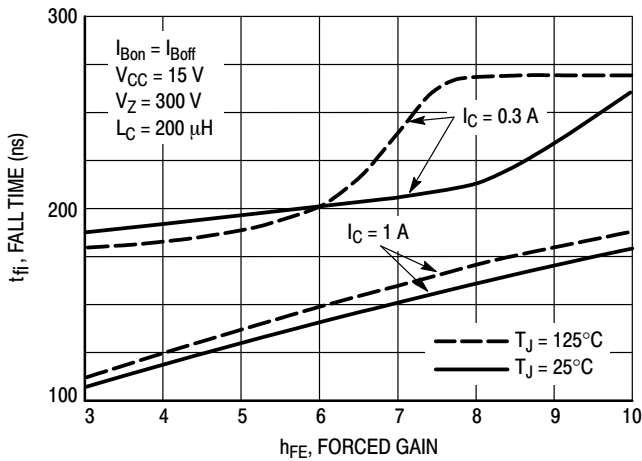


Figure 21. Inductive Fall Time, t_f

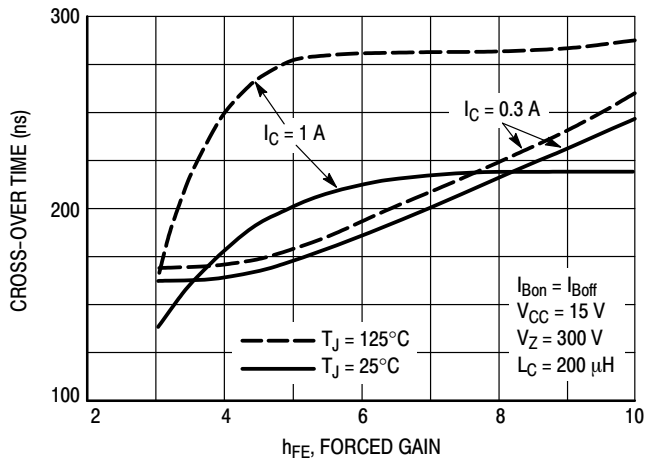


Figure 22. Inductive Cross Over Time, t_c

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TYPICAL SWITCHING CHARACTERISTICS

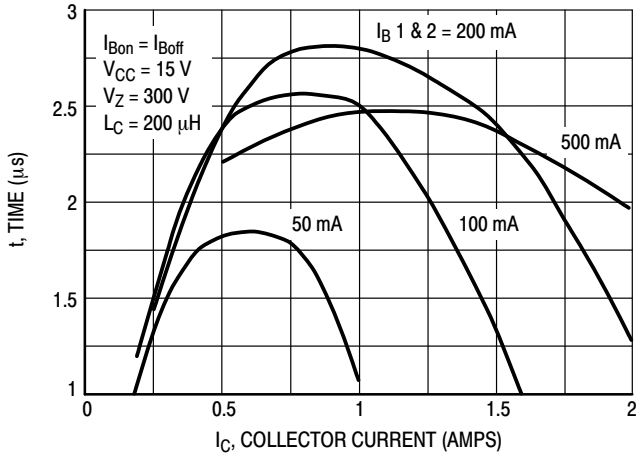


Figure 23. Inductive Storage Time, t_{si}

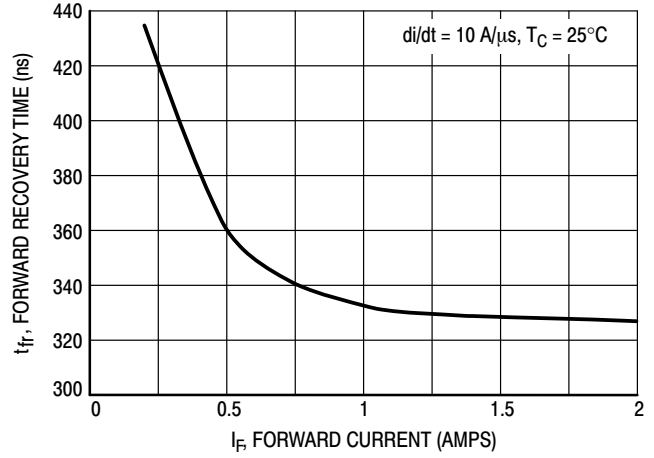


Figure 24. Forward Recovery Time, t_{fr}

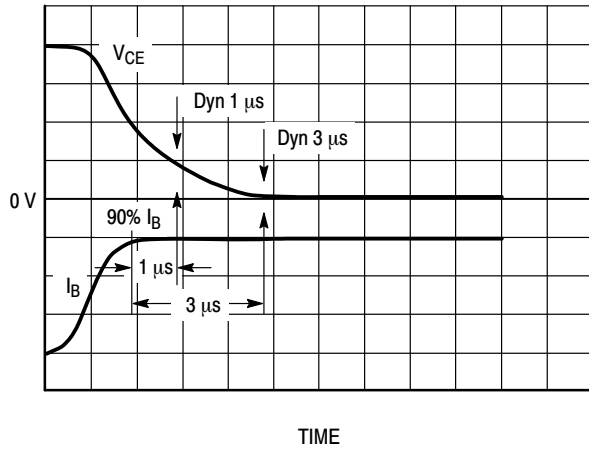


Figure 25. Dynamic Saturation Voltage Measurements

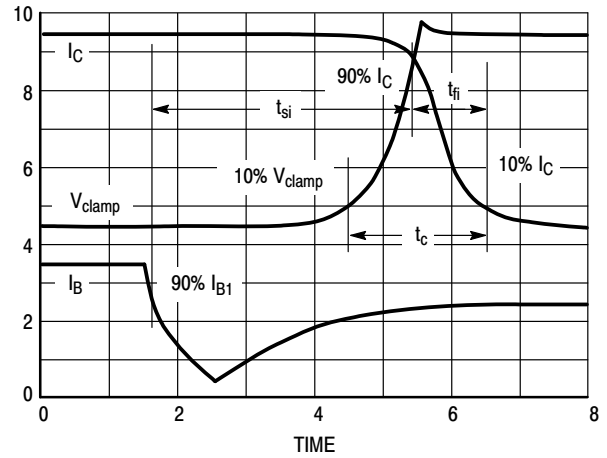
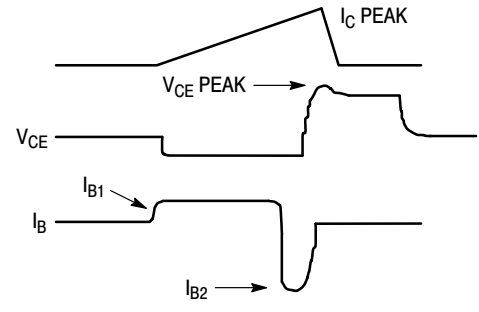
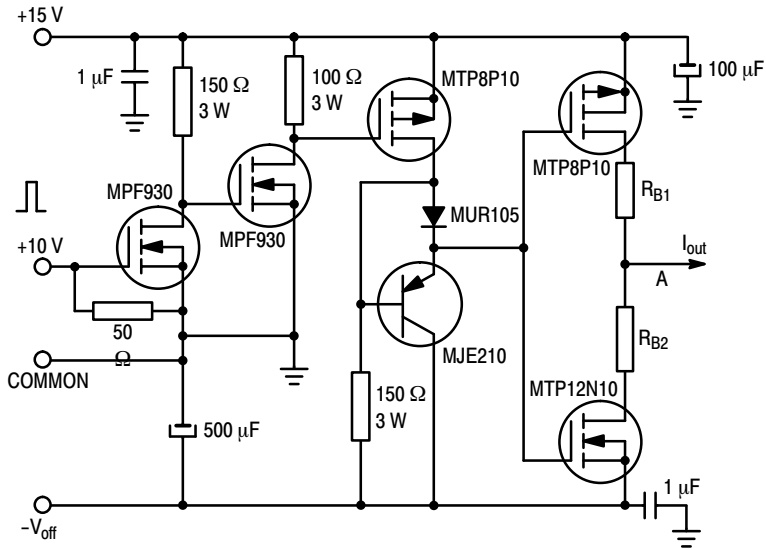


Figure 26. Inductive Switching Measurements

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TYPICAL SWITCHING CHARACTERISTICS

Table 1. Inductive Load Switching Drive Circuit



$V_{(BR)CEO(sus)}$
 $L = 10 \text{ mH}$
 $R_{B2} = \infty$
 $V_{CC} = 20 \text{ Volts}$
 $I_{C(pk)} = 100 \text{ mA}$

Inductive Switching
 $L = 200 \mu\text{H}$
 $R_{B2} = 0$
 $V_{CC} = 15 \text{ Volts}$
 R_{B1} selected for desired I_{B1}

RBSOA
 $L = 500 \mu\text{H}$
 $R_{B2} = 0$
 $V_{CC} = 15 \text{ Volts}$
 R_{B1} selected for desired I_{B1}

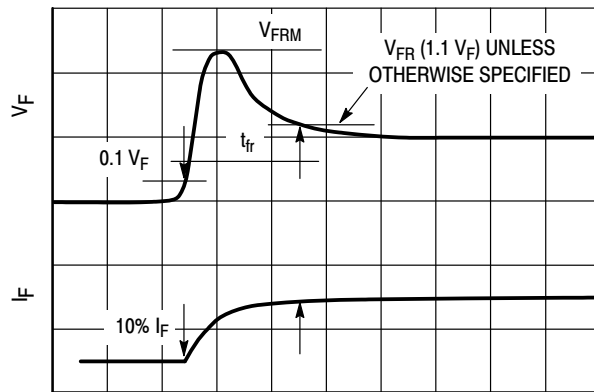


Figure 27. t_{fr} Measurement

BUD42D

MAXIMUM RATINGS

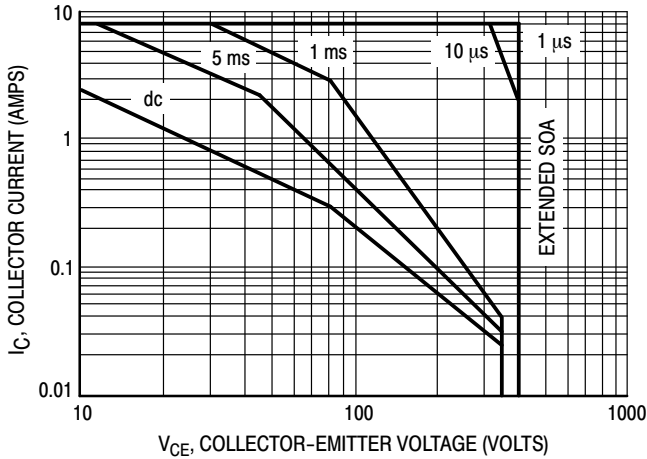


Figure 28. Forward Bias Safe Operating Area

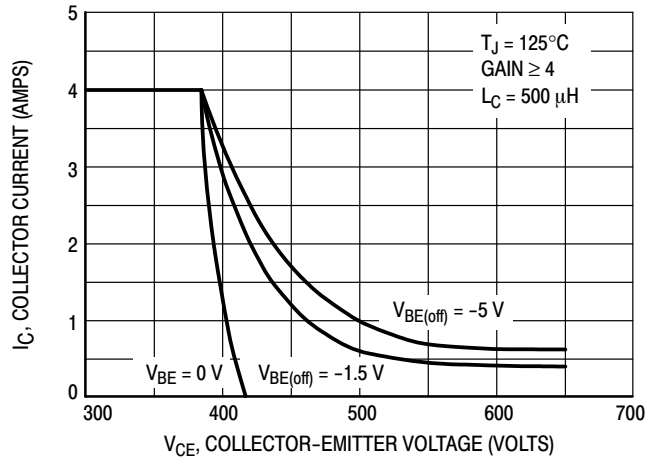


Figure 29. Reverse Bias Safe Operating Area

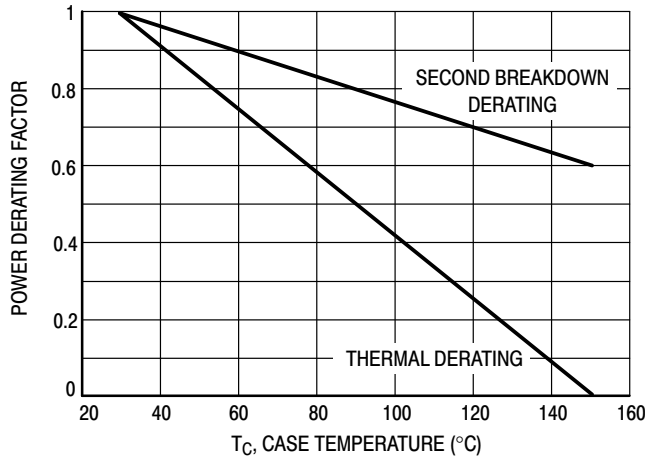


Figure 30. Power Derating

There are two limitations on the power handling ability of a transistor: average junction temperature and second breakdown. Safe operating area curves indicate I_C - V_{CE} limits of the transistor that must be observed for reliable operation; i.e., the transistor must not be subjected to greater dissipation than the curves indicate. The data of Figure 28 is based on $T_C = 25^\circ\text{C}$; $T_{j(pk)}$ is variable depending on power level. Second breakdown pulse limits are valid for duty cycles to 10% but must be derated when $T_C > 25^\circ\text{C}$. Second Breakdown limitations do not derate like thermal limitations. Allowable current at the voltages shown on

Figure 28 may be found at any case temperature by using the appropriate curve on Figure 30.

$T_{j(pk)}$ may be calculated from the data in Figure 31. At any case temperatures, thermal limitations will reduce the power that can be handled to values less than the limitations imposed by second breakdown. For inductive loads, high voltage and current must be sustained simultaneously during turn-off with the base to emitter junction reverse biased. The safe level is specified as reverse biased safe operating area (Figure 29). This rating is verified under clamped conditions so that the device is never subjected to an avalanche mode.

BUD42D

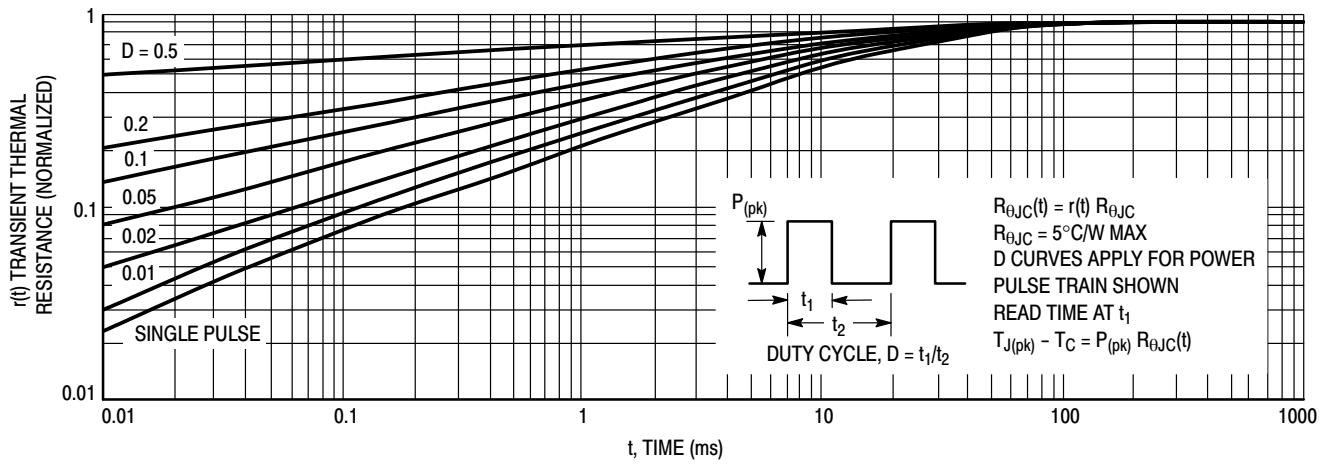


Figure 31. Thermal Response

ORDERING INFORMATION

| Device | Package | Shipping [†] |
|-----------|------------------------------------|--------------------------|
| BUD42D-1G | DPAK Straight Lead (Pb-Free) | 75 Units / Rail |
| BUD42DT4G | DPAK (Pb-Free) | 2500 Units / Tape & Reel |

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

MECHANICAL CASE OUTLINE

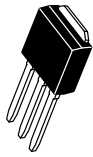
PACKAGE DIMENSIONS

ON Semiconductor®

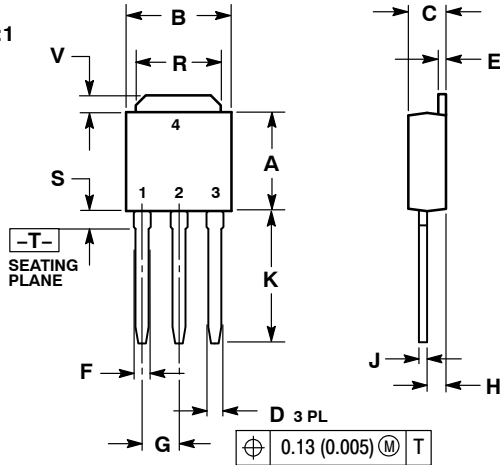


IPAK CASE 369D-01 ISSUE C

DATE 15 DEC 2010



SCALE 1:1

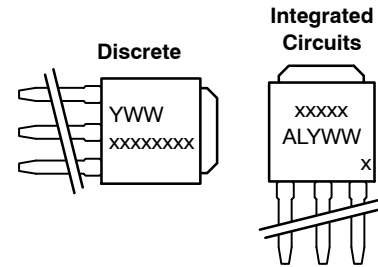


- NOTES:
- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
 - CONTROLLING DIMENSION: INCH.

| DIM | INCHES | | MILLIMETERS | |
|-----|--------|-------|-------------|------|
| | MIN | MAX | MIN | MAX |
| A | 0.235 | 0.245 | 5.97 | 6.35 |
| B | 0.250 | 0.265 | 6.35 | 6.73 |
| C | 0.086 | 0.094 | 2.19 | 2.38 |
| D | 0.027 | 0.035 | 0.69 | 0.88 |
| E | 0.018 | 0.023 | 0.46 | 0.58 |
| F | 0.037 | 0.045 | 0.94 | 1.14 |
| G | 0.090 | BSC | 2.29 | BSC |
| H | 0.034 | 0.040 | 0.87 | 1.01 |
| J | 0.018 | 0.023 | 0.46 | 0.58 |
| K | 0.350 | 0.380 | 8.89 | 9.65 |
| R | 0.180 | 0.215 | 4.45 | 5.45 |
| S | 0.025 | 0.040 | 0.63 | 1.01 |
| V | 0.035 | 0.050 | 0.89 | 1.27 |
| Z | 0.155 | --- | 3.93 | --- |

- | | | | |
|--|---|--|--|
| <p>STYLE 1: PIN 1. BASE 2. COLLECTOR 3. EMITTER 4. COLLECTOR</p> | <p>STYLE 2: PIN 1. GATE 2. DRAIN 3. SOURCE 4. DRAIN</p> | <p>STYLE 3: PIN 1. ANODE 2. CATHODE 3. ANODE 4. CATHODE</p> | <p>STYLE 4: PIN 1. CATHODE 2. ANODE 3. GATE 4. ANODE</p> |
| <p>STYLE 5: PIN 1. GATE 2. ANODE 3. CATHODE 4. ANODE</p> | <p>STYLE 6: PIN 1. MT1 2. MT2 3. GATE 4. MT2</p> | <p>STYLE 7: PIN 1. GATE 2. COLLECTOR 3. EMITTER 4. COLLECTOR</p> | |

MARKING DIAGRAMS

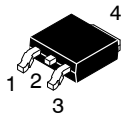


- xxxxxxxx = Device Code
 A = Assembly Location
 IL = Wafer Lot
 Y = Year
 WW = Work Week

| | | |
|-------------------------|------------------------------------|--|
| DOCUMENT NUMBER: | 98AON10528D | Electronic versions are uncontrolled except when accessed directly from the Document Repository. Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red. |
| DESCRIPTION: | IPAK (DPAK INSERTION MOUNT) | PAGE 1 OF 1 |

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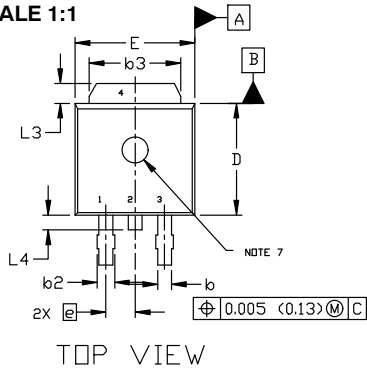
MECHANICAL CASE OUTLINE PACKAGE DIMENSIONS



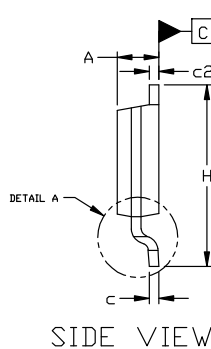
DPAK (SINGLE GAUGE) CASE 369C ISSUE G

DATE 31 MAY 2023

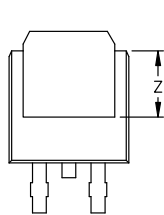
SCALE 1:1



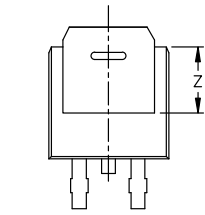
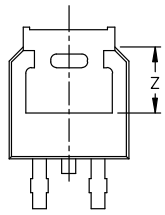
TOP VIEW



SIDE VIEW

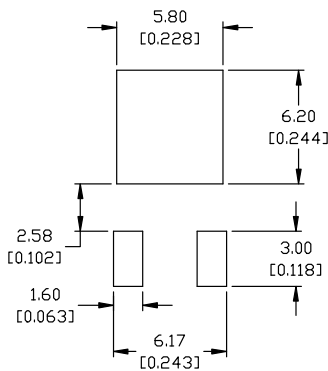


BOTTOM VIEW



BOTTOM VIEW

ALTERNATE CONSTRUCTIONS



RECOMMENDED MOUNTING FOOTPRINT*

*FOR ADDITIONAL INFORMATION ON OUR Pb-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERM/D.

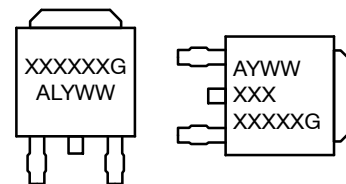
- | | | | | |
|--|--|---|---|--|
| STYLE 1: PIN 1. BASE 2. COLLECTOR 3. EMITTER 4. COLLECTOR | STYLE 2: PIN 1. GATE 2. DRAIN 3. SOURCE 4. DRAIN | STYLE 3: PIN 1. ANODE 2. CATHODE 3. ANODE 4. CATHODE | STYLE 4: PIN 1. CATHODE 2. ANODE 3. GATE 4. ANODE | STYLE 5: PIN 1. GATE 2. ANODE 3. CATHODE 4. ANODE |
| STYLE 6: PIN 1. MT1 2. MT2 3. GATE 4. MT2 | STYLE 7: PIN 1. GATE 2. COLLECTOR 3. EMITTER 4. COLLECTOR | STYLE 8: PIN 1. N/C 2. CATHODE 3. ANODE 4. CATHODE | STYLE 9: PIN 1. ANODE 2. CATHODE 3. RESISTOR ADJUST 4. CATHODE | STYLE 10: PIN 1. CATHODE 2. ANODE 3. CATHODE 4. ANODE |

NOTES:

- DIMENSIONING AND TOLERANCING ASME Y14.5M, 1994.
- CONTROLLING DIMENSION: INCHES
- THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS b3, L3, AND Z.
- DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE.
- DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- DATUMS A AND B ARE DETERMINED AT DATUM PLANE H.
- OPTIONAL MOLD FEATURE.

| DIM | INCHES | | MILLIMETERS | |
|-----|--------|-------|-------------|-------|
| | MIN. | MAX. | MIN. | MAX. |
| A | 0.086 | 0.094 | 2.18 | 2.38 |
| A1 | 0.000 | 0.005 | 0.00 | 0.13 |
| b | 0.025 | 0.035 | 0.63 | 0.89 |
| b2 | 0.028 | 0.045 | 0.72 | 1.14 |
| b3 | 0.180 | 0.215 | 4.57 | 5.46 |
| c | 0.018 | 0.024 | 0.46 | 0.61 |
| c2 | 0.018 | 0.024 | 0.46 | 0.61 |
| D | 0.235 | 0.245 | 5.97 | 6.22 |
| E | 0.250 | 0.265 | 6.35 | 6.73 |
| e | 0.090 | BSC | 2.29 | BSC |
| H | 0.370 | 0.410 | 9.40 | 10.41 |
| L | 0.055 | 0.070 | 1.40 | 1.78 |
| L1 | 0.114 | REF | 2.90 | REF |
| L2 | 0.020 | BSC | 0.51 | BSC |
| L3 | 0.035 | 0.050 | 0.89 | 1.27 |
| L4 | ---- | 0.040 | --- | 1.01 |
| Z | 0.155 | ---- | 3.93 | --- |

GENERIC MARKING DIAGRAM*



- IC**
 XXXXXX = Device Code
 A = Assembly Location
 L = Wafer Lot
 Y = Year
 WW = Work Week
 G = Pb-Free Package
- Discrete**
 AYWW
 XXX
 XXXXXG

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

| | | |
|-------------------------|----------------------------|--|
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| DESCRIPTION: | DPAK (SINGLE GAUGE) | PAGE 1 OF 1 |

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